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**Semiconductor devices -
Part 5-13: Optoelectronic devices - Hydrogen sulphide corrosion test for LED
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CONTENTS

FOREWORD	3
INTRODUCTION	5
INTRODUCTION to Amendment 1	5
1 Scope	6
2 Normative references	6
3 Terms and definitions	6
4 Test apparatus	7
4.1 General	7
4.2 Test jig	7
4.3 Test setup	7
5 Test atmosphere	8
6 Preconditioning	8
6.1 General	8
6.2 Hygroscopic treatment	8
7 Method	9
7.1 Initial measurements	9
7.2 Procedure	9
7.3 Final measurements	10
8 Details to be specified	11
Annex A (informative) Information to predict luminous/radiant flux degradation in particular conditions from the test results	12
A.1 Correspondence relation between hydrogen sulphide corrosion test and indoor corrosivity categories	12
A.2 Correspondence relation between the result of this corrosion test and the corrosion in the field environment (Case example)	13
Annex B (informative) Method for determining the mass increase of silver test pieces	14
B.1 Purpose	14
B.2 Method	14
B.3 Silver test pieces	14
B.4 How to place silver test pieces	14
Annex C (informative) Silver test piece for corrosion monitoring	16
C.1 Specimens	16
C.2 Preparation	16
Annex D (informative) Gas concentrations set up of test atmosphere	17
D.1 General	17
D.2 Reason about no allowable range of each gas concentration	17
D.3 Application of the actual test	17
Bibliography	18
Figure 1 – Example of setup	8
Figure 2 – Example of LED luminous flux maintenance factor before & after hygroscopic treatment	9
Figure A.1 – Mass increase example of silver test piece hydrogen sulphide corrosion test	13
Figure B.1 – Example of layout of silver test pieces	15

Table A.1 – Description of typical environments related to the estimation of indoor corrosivity categories in ISO 11844-1:2006, Table D.3.....	12
Table A.2 – The upper limit of mass increase of silver test pieces in the indoor environment of corrosivity category in ISO 11844-1:2006 for approximately ten years' usage	13

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

Semiconductor devices - Part 5-13: Optoelectronic devices - Hydrogen sulphide corrosion test for LED packages

FOREWORD

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IEC 60747-5-13 edition 1.1 contains the first edition (2021-06) [documents 47E/746/FDIS and 47E/751/RVD] and its amendment 1 (2026-01) [documents 47E/853/CDV and 47E/866/RVC].

In this Redline version, a vertical line in the margin shows where the technical content is modified by amendment 1. Additions are in green text, deletions are in strikethrough red text. A separate Final version with all changes accepted is available in this publication.

IEC 60747-5-13 has been prepared by subcommittee 47E: Discrete semiconductor devices, of IEC technical committee 47: Semiconductor devices. It is an International Standard.

The text of this International Standard is based on the following documents:

FDIS	Report on voting
47E/746/FDIS	47E/751/RVD

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this International Standard is English.

This document was drafted in accordance with ISO/IEC Directives, Part 2, and developed in accordance with ISO/IEC Directives, Part 1 and ISO/IEC Directives, IEC Supplement, available at www.iec.ch/members_experts/refdocs. The main document types developed by IEC are described in greater detail at www.iec.ch/standardsdev/publications.

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